## NOTES:

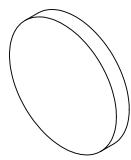
- 1. SUBSTRATE: UV FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- 3. COATING (APPLY ACROSS COATING APERTURE)
  - \$1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 408 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 390nm @ 0° AOI T(abs): =50% FOR 400±4nm @ 0° AOI

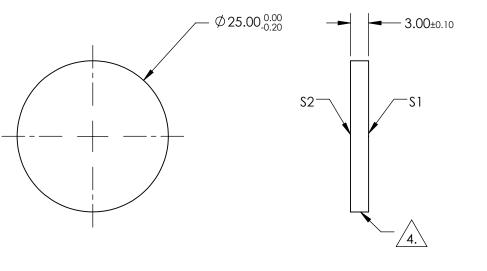
S2:SINGLE LAYER MgF2

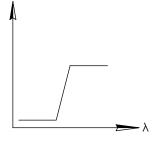
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm (prior to coating)
- 7. ROHS COMPLIANT









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## SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

LONGPASS FILTER					Edmund Optic	<b>C</b> ®
	S1	\$2				5
SHAPE	PLANO	PLANO		TITLE	Ø25mm, 400nm, HIGH PERFORMANCE LONGPASS FILTER	
SURFACE QUALITY	60-40	60-40				
CLEAR APERTURE	>80%	>80%	]			CUEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	62981	SHEET 1 OF 1